Search Notes		
	e i i e iko iioio ikoik	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/822,960	LEE ET AL.	
Examiner	Art Unit	
Andy Huynh	2818	

SEARCHED			
Class	Subclass	Date	Examiner
		•	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			-

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (text search)	10/6/2006	АН
PLUS Search	10/6/2006	. AH
. ,	·	
·		
·		